Applicant(s)/Patent Under Application/Control No. Reexamination 10/763,206 NAKAMURA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Christopher RoDee 1756 **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY US-Α US-В С US-US-D US-Ε US-F US-G USн US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) Alger, Mark S. Polymer Science Dictionary. London, Elsevier Applied Science. (1989) p. 185. V

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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